

# Kaleo MultiWAVE multi-wavelength,

Iarge dynamic range interferometer





# INTERFEROMETRIC SOLUTION FOR FILTERS AND COATED OPTICS TESTING AT DEDICATED WAVELENGTHS

PHASICS is innovating in optical metrology with a new instrument able to measure both transmitted and reflected wavefront error (TWE/ RWE). Coated and uncoated optics can be gualified over a diameter of 5.1 inches (130 mm) at their working wavelengths.

Kaleo MultiWAVE is an advantageous alternative and cost-effective solution to the purchase of several interferometers. The system offers measurement accuracy comparable to Fizeau interferometry. a

Kaleo **MultiWAVE** works different wavelengths perform at to qualification of optics and coatings at their working wavelengths.

## **KEY FEATURES**

Up to 8 wavelengths



range

High dynamic WFE & MTF measurement

Insensitive to vibration Compatible with MetroPro & ISO

**PHASICS** - The phase control company



### HIGH DYNAMIC RANGE

#### MEASUREMENT OF LARGE ABERRATIONS

 More than 20 of aberration can be measured with Kaleo MultiWAVE

<sup>o</sup> More dynamic range than a classical Fizeau interferometer

RWE of 5" wide band pass filter at 653nm



 Coated optics and filters testing at real operating wavelengths

• High dynamics surface testing







#### **ACHROMATIC SYSTEM**

Same results at any wavelength

The instrument can be used at any wavelength to match the sample's operating wavelength

# SYSTEM

Configuration	Double pass		
Measurement capability	RWE of reflective surfaces TWE of transparent optics		
Number of wavelengths per instrument	1 or 2 (standard), up to 8 (custom)		
Custom wavelengths	Any wavelength from 193 nm to 14μm inculding: UV: 266, 355, 405 nm VIS/NIR: 550, 625, 780, 940, 1050 nm SWIR/MWR/LWIR: 1.55, 2.0, 3.39, 10.6 μm		
Clear aperture	5.1" (130 mm)		
Beam height	108 mm		
Alignment system	Live phase & Zernike cofficients dis- play		
Polarization	Compatible with depolarizing optics		
Alignment FOV	+/- 2°		
Pupil focus range	+/- 2.5 m		
Dimension/Weight	910x600x260 mm³ , 25kg		
Vibration isolation	Not necessary		

# **PERFORMANCES**<sup>(1)</sup>

RMS repeatability <sup>(2)</sup>	<0.7 nm (< \/900)
Accuracy <sup>(3)</sup>	80 nm PV
Dynamic range (defocus)	500 fringes (SFE=150 μm)
Sample reflectivity range	~4% - 100%

(1) On a 4" pupil size, with a 625 nm source.

(2) 36 sequential measurements are performed on a 4" reference mirror, each being averaged 16 times. A reference is defined as the average of all odd numbered measurements. RMS repeatability is then defined as the average RMS difference plus 2 times the standard deviation of the difference between even numbered measurements and the reference.

(3) For a  $1 \mu m$  PV defocus.

# **RESULTS SIMILAR TO FIZEAU INTERFEROMETRY**



NBP-780nm

The difference between the 2 measurements on the same pupil is below 40 nm PtV

		FIZEAU	PHASICS
Diameter (mm)		124.9	125.4
RWE (nm PtV)		1498.13	1535.38
RWE (nm RMS) without PST/TLT/PWR		35.2	28.1
RWE (nm RMS) without ST/TLT/PWR/AST/CMA/SA		9.1	12.9
ISO 10110	SAG (fr)	5.13	5.04
	IRR (fr)	0.75	0.61
	RSI (fr)	0.34	0.23
	RMSt (fr)	1.477	1.459
	RMSi (fr)	0.129	0.103
	RMSa (fr)	0.085	0.059

### MARKETS



Space & Defense





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